# Low-Voltage CMOS 16-Bit Buffer

# With 5 V-Tolerant Inputs and Outputs (3-State, Non-Inverting)

The MC74LCX16244 is a high performance, non–inverting 16–bit buffer operating from a 2.3 to 3.6 V supply. The device is nibble controlled. Each nibble has separate Output Enable inputs which can be tied together for full 16–bit operation. High impedance TTL compatible inputs significantly reduce current loading to input drivers while TTL compatible outputs offer improved switching noise performance. A  $V_{\rm I}$  specification of 5.5 V allows MC74LCX16244 inputs to be safely driven from 5.0 V devices. The MC74LCX16244 is suitable for memory address driving and all TTL level bus oriented transceiver applications.

The 4.5 ns maximum propagation delays support high performance applications. Current drive capability is 24 mA at the outputs. The Output Enable  $(\overline{OEn})$  inputs, when HIGH, disable the outputs by placing them in a HIGH Z condition.

The MC74LCX16244 contains sixteen non–inverting buffers with 3–state 5.0 V–tolerant outputs. The device is nibble controlled with each nibble functioning identically, but independently. The control pins may be tied together to obtain full 16–bit operation. The 3–state outputs are controlled by an Output Enable  $(\overline{OEn})$  input for each nibble. When  $\overline{OEn}$  is LOW, the outputs are on. When  $\overline{OEn}$  is HIGH, the outputs are in the high impedance state.

#### **Features**

- Designed for 2.3 V to 3.6 V V<sub>CC</sub> Operation
- 4.5 ns Maximum t<sub>pd</sub>
- 5.0 V Tolerant Interface Capability With 5.0 V TTL Logic
- Supports Live Insertion and Withdrawal
- $I_{OFF}$  Specification Guarantees High Impedance When  $V_{CC} = 0 \text{ V}$
- LVTTL Compatible
- LVCMOS Compatible
- 24 mA Balanced Output Sink and Source Capability
- Near Zero Static Supply Current in All Three Logic States (20 μA) Substantially Reduces System Power Requirements
- Latchup Performance Exceeds 500 mA
- ESD Performance: Human Body Model >2000 V; Machine Model >200 V
- These are Pb-Free Devices\*



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TSSOP-48 DT SUFFIX CASE 1201

#### **MARKING DIAGRAM**

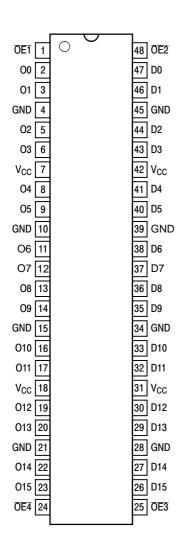
A = Assembly Location

WL = Wafer Lot
 YY = Year
 WW = Work Week
 G = Pb-Free Package

#### ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 3 of this data sheet.

<sup>\*</sup>For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.



**Table 1. PIN NAMES** 

| Pins   | Function             |
|--------|----------------------|
| OEn    | Output Enable Inputs |
| D0-D15 | Inputs               |
| O0-O15 | Outputs              |

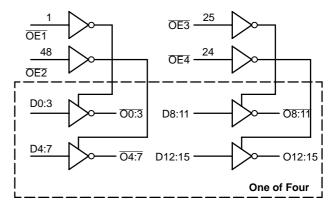


Figure 2. Logic Diagram

Figure 1. Pinout: 48-Lead (Top View)

# **TRUTH TABLE**

| OE1 | D0:3 | O0:3 | OE2 | D4:7 | O4:7 | OE3 | D8:11 | O8:11 | OE4 | D12:15 | O12:15 |
|-----|------|------|-----|------|------|-----|-------|-------|-----|--------|--------|
| L   | L    | L    | L   | L    | L    | L   | L     | L     | L   | L      | L      |
| L   | Н    | Н    | L   | Н    | Н    | L   | Н     | Н     | L   | Н      | Н      |
| Н   | Х    | Z    | Н   | Х    | Z    | Н   | Х     | Z     | Н   | Х      | Z      |

H = High Voltage Level
L = Low Voltage Level
Z = High Impedance State

X = High or Low Voltage Level and Transitions Are Acceptable; for I<sub>CC</sub> reasons, DO NOT FLOAT Inputs.

# **ORDERING INFORMATION**

| Device           | Package   | Shipping <sup>†</sup> |
|------------------|-----------|-----------------------|
| MC74LCX16244DT   | TSSOP-48* | 39 Units / Rail       |
| MC74LCX16244DTG  | TSSOP-48* | 39 Units / Rail       |
| MC74LCX16244DTR2 | TSSOP-48* | 2500 / Tape & Reel    |
| M74LCX16244DTR2G | TSSOP-48* | 2500 / Tape & Reel    |

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

# **MAXIMUM RATINGS**

| Symbol           | Parameter                        | Value                             | Condition                            | Unit |
|------------------|----------------------------------|-----------------------------------|--------------------------------------|------|
| V <sub>CC</sub>  | DC Supply Voltage                | -0.5 to +7.0                      |                                      | V    |
| VI               | DC Input Voltage                 | $-0.5 \le V_1 \le +7.0$           |                                      | V    |
| Vo               | DC Output Voltage                | $-0.5 \le V_0 \le +7.0$           | Output in 3-State                    | V    |
|                  |                                  | $-0.5 \le V_{O} \le V_{CC} + 0.5$ | Output in HIGH or LOW State (Note 1) | V    |
| I <sub>IK</sub>  | DC Input Diode Current           | <b>-50</b>                        | V <sub>I</sub> < GND                 | mA   |
| I <sub>OK</sub>  | DC Output Diode Current          | <b>-50</b>                        | V <sub>O</sub> < GND                 | mA   |
|                  |                                  | +50                               | V <sub>O</sub> > V <sub>CC</sub>     | mA   |
| I <sub>O</sub>   | DC Output Source/Sink Current    | ±50                               |                                      | mA   |
| I <sub>CC</sub>  | DC Supply Current Per Supply Pin | ±100                              |                                      | mA   |
| I <sub>GND</sub> | DC Ground Current Per Ground Pin | ±100                              |                                      | mA   |
| T <sub>STG</sub> | Storage Temperature Range        | -65 to +150                       |                                      | °C   |

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

# **RECOMMENDED OPERATING CONDITIONS**

| Symbol          | Parameter   | Min                                 | Тур                  | Max                    | Unit |
|-----------------|---|-------------------------------------|----------------------|------------------------|------|
| V <sub>CC</sub> | Supply Voltage C Data Retent  | perating 2.0 ion Only 1.5           | 2.5, 3.3<br>2.5, 3.3 | 3.6<br>3.6             | V    |
| VI              | Input Voltage   | 0                                   |                      | 5.5                    | V    |
| V <sub>O</sub>  | Output Voltage (HIGH or LO'   | N State)     0       3-State)     0 |                      | V <sub>CC</sub><br>5.5 | V    |
| I <sub>OH</sub> | HIGH Level Output Current $ \begin{array}{c} V_{CC} = 3.0 \ \text{V}_{CC} = 2.7 \ \text{V}_{CC} = 2.3 \ \text{V}_{CC} \end{array} $ | ′ – 3.0 V                           |                      | -24<br>-12<br>-8       | mA   |
| I <sub>OL</sub> | LOW Level Output Current $ \begin{array}{c} V_{CC} = 3.0 \ \text{V} \\ V_{CC} = 2.7 \ \text{V} \\ CC = 2.3 \ \text{V} \end{array} $ | ′ – 3.0 V                           |                      | +24<br>+12<br>+8       | mA   |
| T <sub>A</sub>  | Operating Free-Air Temperature  | -40                                 |                      | +85                    | °C   |
| Δt/ΔV           | Input Transition Rise or Fall Rate, $V_{\text{IN}}$ from 0.8 V to 2.0 V, V  | CC = 3.0 V 0                        |                      | 10                     | ns/V |

<sup>\*</sup>This package is inherently Pb–Free.

<sup>1.</sup> I<sub>O</sub> absolute maximum rating must be observed.

# DC ELECTRICAL CHARACTERISTICS

|                  |                                       |   | T <sub>A</sub> = -40°C |      |      |  |
|------------------|---------------------------------------|---|------------------------|------|------|--|
| Symbol           | Characteristic                        | Condition   | Min                    | Max  | Unit |  |
| V <sub>IH</sub>  | HIGH Level Input Voltage (Note 2)     | 2.3 V ≤ V <sub>CC</sub> ≤ 2.7 V   | 1.7                    |      | V    |  |
|                  |                                       | 2.7 V ≤ V <sub>CC</sub> ≤ 3.6 V   | 2.0                    |      |      |  |
| $V_{IL}$         | LOW Level Input Voltage (Note 2)      | 2.3 V ≤ V <sub>CC</sub> ≤ 2.7 V   |                        | 0.7  | V    |  |
|                  |                                       | 2.7 V ≤ V <sub>CC</sub> ≤ 3.6 V   |                        | 0.8  |      |  |
| V <sub>OH</sub>  | HIGH Level Output Voltage             | $2.3 \text{ V} \le \text{V}_{CC} \le 3.6 \text{ V}; \text{ I}_{OL} = 100 \mu\text{A}$                       | V <sub>CC</sub> – 0.2  |      | V    |  |
|                  |                                       | $V_{CC} = 2.3 \text{ V; } I_{OH} = -8 \text{ mA}$   | 1.8                    |      |      |  |
|                  |                                       | $V_{CC} = 2.7 \text{ V}; I_{OH} = -12 \text{ mA}$   | 2.2                    |      |      |  |
|                  |                                       | $V_{CC} = 3.0 \text{ V}; I_{OH} = -18 \text{ mA}$   | 2.4                    |      |      |  |
|                  |                                       | $V_{CC} = 3.0 \text{ V; } I_{OH} = -24 \text{ mA}$  | 2.2                    |      |      |  |
| V <sub>OL</sub>  | LOW Level Output Voltage              | $2.3 \text{ V} \le \text{V}_{CC} \le 3.6 \text{ V}; \text{I}_{OL} = 100 \mu\text{A}$                        |                        | 0.2  | V    |  |
|                  |                                       | V <sub>CC</sub> = 2.3 V; I <sub>OL</sub> = 8 mA   |                        | 0.6  |      |  |
|                  |                                       | V <sub>CC</sub> = 2.7 V; I <sub>OL</sub> = 12 mA  |                        | 0.4  |      |  |
|                  |                                       | V <sub>CC</sub> = 3.0 V; I <sub>OL</sub> = 16 mA  |                        | 0.4  |      |  |
|                  |                                       | $V_{CC} = 3.0 \text{ V}; I_{OL} = 24 \text{ mA}$  |                        | 0.55 |      |  |
| I <sub>I</sub>   | Input Leakage Current                 | $2.3 \text{ V} \le \text{V}_{CC} \le 3.6 \text{ V}; 0 \text{ V} \le \text{V}_{I} \le 5.5 \text{ V}$         |                        | ±5.0 | μΑ   |  |
| I <sub>OZ</sub>  | 3-State Output Current                | $2.3 \le V_{CC} \le 3.6 \text{ V}; \ 0V \le V_{O} \le 5.5 \text{ V}; \ V_{I} = V_{IH} \ \text{or} \ V_{IL}$ |                        | ±5.0 | μΑ   |  |
| I <sub>OFF</sub> | Power-Off Leakage Current             | $V_{CC} = 0 \text{ V; } V_{I} \text{ or } V_{O} = 5.5 \text{ V}$  |                        | 10   | μΑ   |  |
| I <sub>CC</sub>  | Quiescent Supply Current              | $2.3 \le V_{CC} \le 3.6 \text{ V}; V_I = \text{GND or } V_{CC}$   |                        | 20   | μΑ   |  |
|                  |                                       | $2.3 \le V_{CC} \le 3.6 \text{ V}; 3.6 \le V_{I} \text{ or } V_{O} \le 5.5 \text{ V}$                       |                        | ±20  | μΑ   |  |
| $\Delta I_{CC}$  | Increase in I <sub>CC</sub> per Input | $2.3 \le V_{CC} \le 3.6 \text{ V}; V_{IH} = V_{CC} - 0.6 \text{ V}$   |                        | 500  | μΑ   |  |

<sup>2.</sup> These values of V<sub>I</sub> are used to test DC electrical characteristics only.

# AC CHARACTERISTICS $t_R = t_F = 2.5 \text{ ns}; R_L = 500 \ \Omega$

|  | $T_A = -40^{\circ}C \text{ to } +85^{\circ}C$  |          |            |                    |                                      |            |   |            |      |
|--|--|----------|------------|--------------------|--------------------------------------|------------|---|------------|------|
|  |  |          |            | V ± 0.3 V<br>50 pF | V <sub>CC</sub> = C <sub>L</sub> = 9 |            | V <sub>CC</sub> = 2.5<br>C <sub>L</sub> = 3 |            |      |
| Symbol                                 | Parameter                                      | Waveform | Min        | Max                | Min                                  | Max        | Min   | Max        | Unit |
| t <sub>PLH</sub><br>t <sub>PHL</sub>   | Propagation Delay<br>Input to Output           | 1        | 1.5<br>1.5 | 4.5<br>4.5         | 1.5<br>1.5                           | 5.2<br>5.2 | 1.5<br>1.5                                  | 5.4<br>5.4 | ns   |
| t <sub>PZH</sub><br>t <sub>PZL</sub>   | Output Enable Time to<br>High and Low Level    | 2        | 1.5<br>1.5 | 5.5<br>5.5         | 1.5<br>1.5                           | 6.3<br>6.3 | 1.5<br>1.5                                  | 7.2<br>7.2 | ns   |
| t <sub>PHZ</sub><br>t <sub>PLZ</sub>   | Output Disable Time From<br>High and Low Level | 2        | 1.5<br>1.5 | 5.4<br>5.4         | 1.5<br>1.5                           | 5.7<br>5.7 | 1.5<br>1.5                                  | 6.5<br>6.5 | ns   |
| t <sub>OSHL</sub><br>t <sub>OSLH</sub> | Output-to-Output Skew (Note 3)                 |          |            | 1.0<br>1.0         |                                      |            |   |            | ns   |

<sup>3.</sup> Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device. The specification applies to any outputs switching in the same direction, either HIGH–to–LOW (t<sub>OSHL</sub>) or LOW–to–HIGH (t<sub>OSLH</sub>); parameter guaranteed by design.

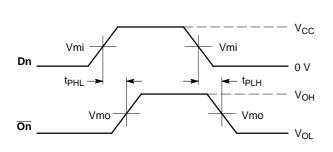
# **DYNAMIC SWITCHING CHARACTERISTICS**

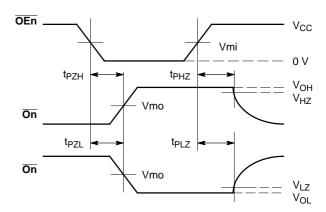
|                  |  |  | T <sub>A</sub> = +25°C |              |     |        |
|------------------|--|--|------------------------|--------------|-----|--------|
| Symbol           | Characteristic                         | Condition  | Min                    | Тур          | Max | Unit   |
| V <sub>OLP</sub> | Dynamic LOW Peak Voltage<br>(Note 4)   | $V_{CC} = 3.3 \text{ V}, C_L = 50 \text{ pF}, V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$<br>$V_{CC} = 2.5 \text{ V}, C_L = 30 \text{ pF}, V_{IH} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}$   |                        | 0.8<br>0.6   |     | V      |
| V <sub>OLV</sub> | Dynamic LOW Valley Voltage<br>(Note 4) | $V_{CC} = 3.3 \text{ V}, C_L = 50 \text{ pF}, V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V} $<br>$V_{CC} = 2.5 \text{ V}, C_L = 30 \text{ pF}, V_{IH} = 2.5 \text{ V}, V_{IL} = 0 \text{ V} $ |                        | -0.8<br>-0.6 |     | V<br>V |

<sup>4.</sup> Number of outputs defined as "n". Measured with "n-1" outputs switching from HIGH-to-LOW or LOW-to-HIGH. The remaining output is measured in the LOW state.

# **CAPACITIVE CHARACTERISTICS**

| Symbol           | Parameter                     | Condition  | Typical | Unit |
|------------------|-------------------------------|--|---------|------|
| C <sub>IN</sub>  | Input Capacitance             | $V_{CC} = 3.3 \text{ V}, V_{I} = 0 \text{ V or } V_{CC}$ | 7       | pF   |
| C <sub>OUT</sub> | Output Capacitance            | $V_{CC}$ = 3.3 V, $V_{I}$ = 0 V or $V_{CC}$              | 8       | pF   |
| C <sub>PD</sub>  | Power Dissipation Capacitance | 10 MHz, $V_{CC}$ = 3.3 V, $V_{I}$ = 0 V or $V_{CC}$      | 20      | pF   |





# **WAVEFORM 1 - PROPAGATION DELAYS**

 $t_R = t_F = 2.5 \text{ ns}, 10\% \text{ to } 90\%; f = 1 \text{ MHz}; t_W = 500 \text{ ns}$ 

# **WAVEFORM 2 - OUTPUT ENABLE AND DISABLE TIMES**

 $t_R = t_F = 2.5 \text{ ns}$ , 10% to 90%; f = 1 MHz;  $t_W = 500 \text{ ns}$ 

Figure 3. AC Waveforms

**Table 2. AC WAVEFORMS** 

|                 | V <sub>CC</sub>         |                         |                          |  |  |  |
|-----------------|-------------------------|-------------------------|--------------------------|--|--|--|
| Symbol          | 3.3 V $\pm$ 0.3 V       | 2.7 V                   | 2.5 V ± 0.2 V            |  |  |  |
| Vmi             | 1.5 V                   | 1.5 V                   | V <sub>CC</sub> / 2      |  |  |  |
| Vmo             | 1.5 V                   | 1.5 V                   | V <sub>CC</sub> / 2      |  |  |  |
| V <sub>HZ</sub> | V <sub>OL</sub> + 0.3 V | V <sub>OL</sub> + 0.3 V | V <sub>OL</sub> + 0.15 V |  |  |  |
| $V_{LZ}$        | V <sub>OH</sub> – 0.3 V | V <sub>OH</sub> – 0.3 V | V <sub>OH</sub> – 015 V  |  |  |  |

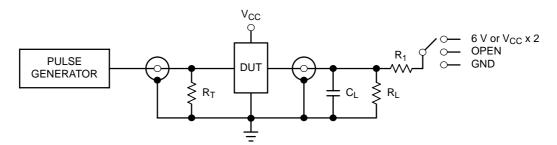


Figure 4. Test Circuit

**Table 3. TEST CIRCUIT** 

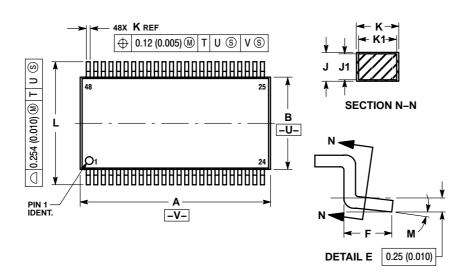
| TEST   | SWITCH  |
|--|---|
| t <sub>PLH</sub> , t <sub>PHL</sub>                        | Open  |
| tpzl, tplz   | 6 V at $V_{CC}$ = 3.3 $\pm$ 0.3 V 6 V at $V_{CC}$ = 2.5 $\pm$ 0.2 V |
| Open Collector/Drain t <sub>PLH</sub> and t <sub>PHL</sub> | 6 V   |
| t <sub>PZH</sub> , t <sub>PHZ</sub>                        | GND   |

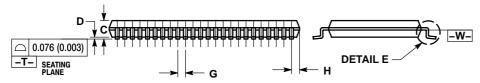
 $C_L$  = 50 pF at  $V_{CC}$  =  $3.3\pm0.3$  V or equivalent (includes jig and probe capacitance)  $C_L$  = 30 pF at  $V_{CC}$  =  $2.5\pm0.2$  V or equivalent (includes jig and probe capacitance)  $R_L$  =  $R_1$  =  $500~\Omega$  or equivalent

 $R_T = Z_{OUT}$  of pulse generator (typically 50  $\Omega$ )

#### **PACKAGE DIMENSIONS**

# TSSOP-48 **DT SUFFIX** CASE 1201-01 **ISSUE A**





- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: MILLIMETER.

- 2. CONTROLLING DIMENSION: MILLIMETER.
  3. DIMENSIONS A AND B DO NOT INCLUDE
  MOLD FLASH, PROTRUSIONS OR GATE
  BURRS. MOLD FLASH OR GATE BURRS
  SHALL NOT EXCEED 0.15 (0.006) PER SIDE.
  4. DIMENSION K DOES NOT INCLUDE DAMBAR
  PROTRUSION. ALLOWABLE DAMBAR
  PROTRUSION SHALL BE 0.08 (0.003) TOTAL IN
  EXCESS OF THE K DIMENSION AT MAXIMUM
  MATERIAL CONDITION.
  5. TERMINAL NUMBERS ARE SHOWN FOR
  REFERENCE ONLY.
  6. DIMENSIONS A AND B ARE TO BE
  DETERMINED AT DATUM PLANE W-

|     | MILLIN | IETERS | INC        | HES   |  |
|-----|--------|--------|------------|-------|--|
| DIM | MIN    | MAX    | MIN        | MAX   |  |
| Α   | 12.40  | 12.60  | 0.488      | 0.496 |  |
| В   | 6.00   | 6.20   | 0.236      | 0.244 |  |
| С   |        | 1.10   |            | 0.043 |  |
| D   | 0.05   | 0.15   | 0.002      | 0.006 |  |
| F   | 0.50   | 0.75   | 0.020      | 0.030 |  |
| G   | 0.50   | BSC    | 0.0197 BSC |       |  |
| Н   | 0.37   |        | 0.015      |       |  |
| J   | 0.09   | 0.20   | 0.004      | 0.008 |  |
| J1  | 0.09   | 0.16   | 0.004      | 0.006 |  |
| K   | 0.17   | 0.27   | 0.007      | 0.011 |  |
| K1  | 0.17   | 0.23   | 0.007      | 0.009 |  |
| L   | 7.95   | 8.25   | 0.313      | 0.325 |  |
| M   | 0 °    | 8 °    | 0 °        | 8 °   |  |

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